

FET-Input, Low Distortion OPERATIONAL AMPLIFIER

FEATURES

- LOW DISTORTION: 0.0003% at 1kHz
- LOW NOISE: $10\text{nV}/\sqrt{\text{Hz}}$
- HIGH SLEW RATE: $25\text{V}/\mu\text{s}$
- WIDE GAIN-BANDWIDTH: 20MHz
- UNITY-GAIN STABLE
- WIDE SUPPLY RANGE: $V_s = \pm 4.5$ to $\pm 24\text{V}$
- DRIVES 600Ω LOAD
- DUAL VERSION AVAILABLE (OPA2604)

DESCRIPTION

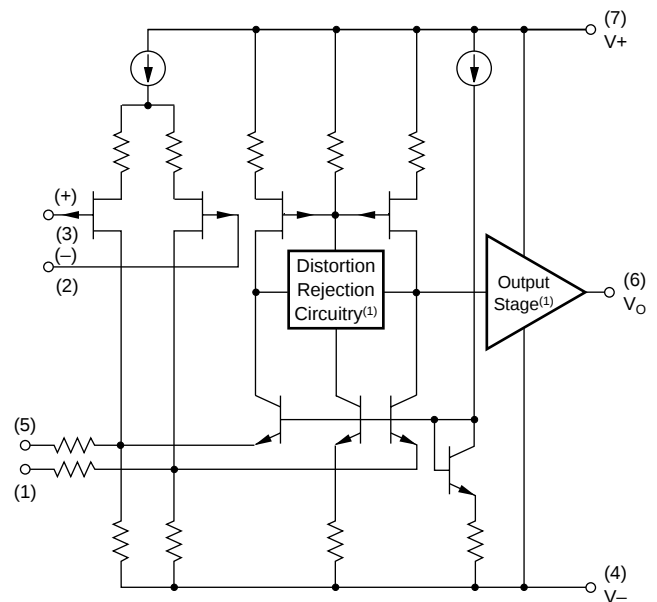
The OPA604 is a FET-input operational amplifier designed for enhanced AC performance. Very low distortion, low noise and wide bandwidth provide superior performance in high quality audio and other applications requiring excellent dynamic performance.

New circuit techniques and special laser trimming of dynamic circuit performance yield very low harmonic distortion. The result is an op amp with exceptional sound quality. The low-noise FET input of the OPA604 provides wide dynamic range, even with high source impedance. Offset voltage is laser-trimmed to minimize the need for interstage coupling capacitors.

The OPA604 is available in 8-pin plastic mini-DIP and SO-8 surface-mount packages, specified for the -25°C to $+85^\circ\text{C}$ temperature range.

APPLICATIONS

- PROFESSIONAL AUDIO EQUIPMENT
- PCM DAC I/V CONVERTERS
- SPECTRAL ANALYSIS EQUIPMENT
- ACTIVE FILTERS
- TRANSDUCER AMPLIFIERS
- DATA ACQUISITION



NOTE: (1) Patents Granted: #5053718, 5019789



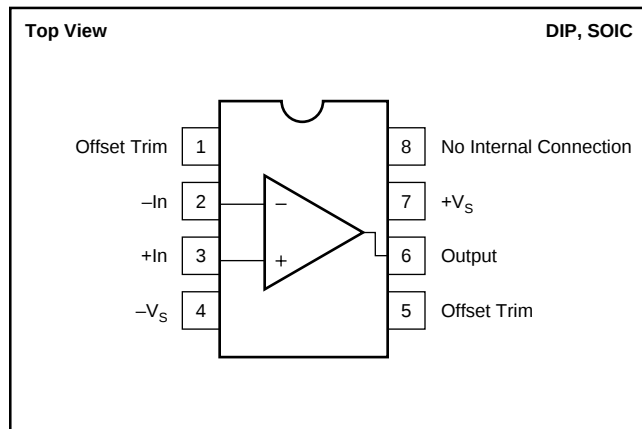
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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ABSOLUTE MAXIMUM RATINGS

Power Supply Voltage	±25V
Input Voltage	(V ₋) -1V to (V ₊) +1V
Output Short Circuit to Ground	Continuous
Operating Temperature	-40°C to +100°C
Storage Temperature	-40°C to +125°C
Junction Temperature	+150°C
Lead Temperature (soldering, 10s) AP	+300°C
Lead Temperature (soldering, 3s) AU	+260°C

PIN CONFIGURATION



ELECTROSTATIC DISCHARGE SENSITIVITY

Any integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet published specifications.

PACKAGE/ORDERING INFORMATION

For the most current package and ordering information, see to the Package Option Addendum at the end of this data sheet.

ELECTRICAL CHARACTERISTICS

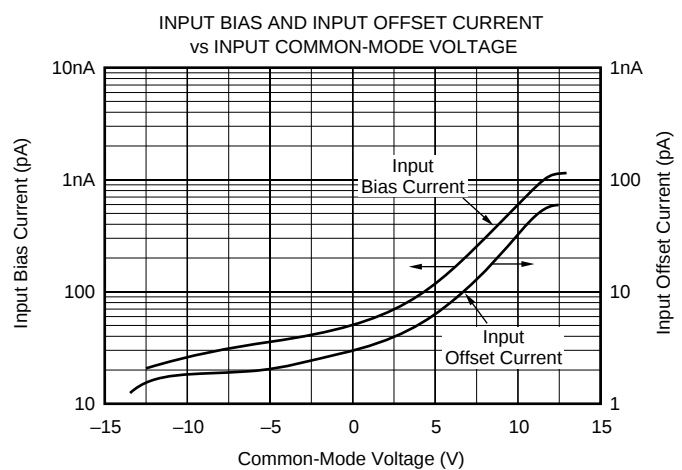
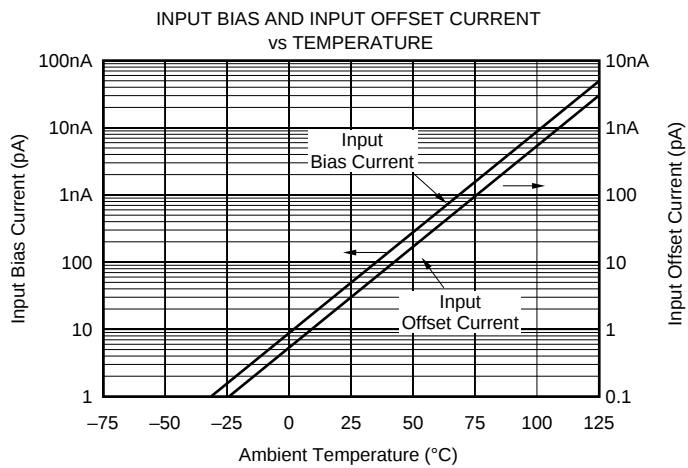
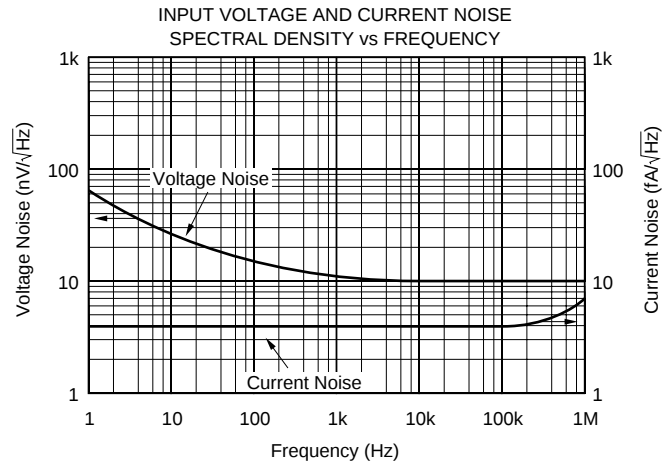
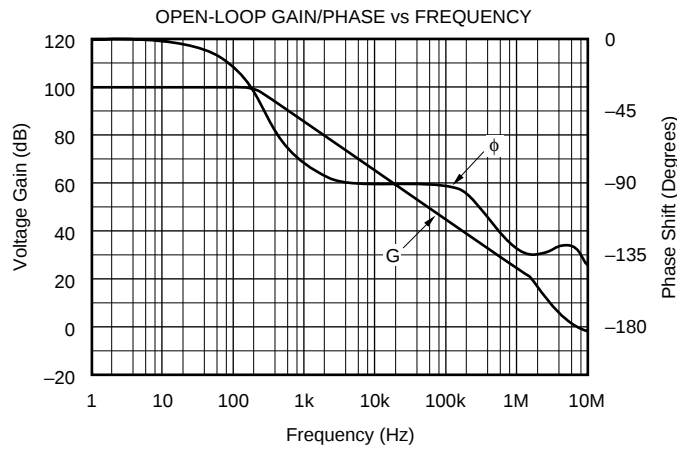
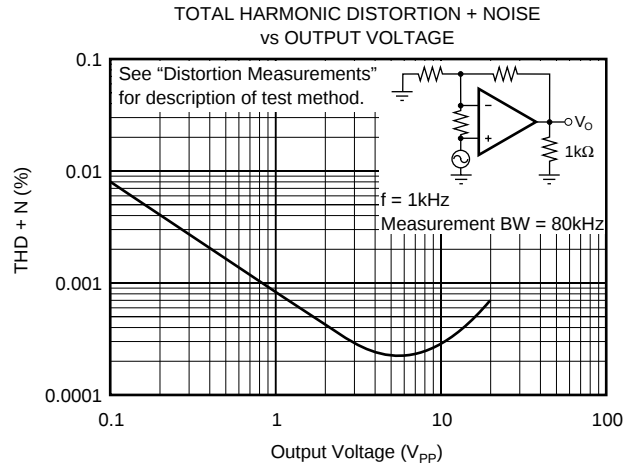
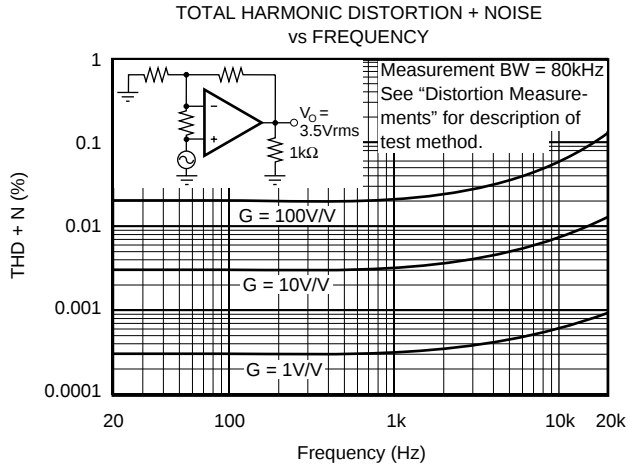
T_A = +25°C, V_S = ±15V, unless otherwise noted.

PARAMETER	CONDITION	OPA604AP, AU			UNITS
		MIN	TYP	MAX	
OFFSET VOLTAGE Input Offset Voltage Average Drift Power Supply Rejection	V _S = ±5 to ±24V	80	±1 ±8 100	±5	mV μV/°C dB
INPUT BIAS CURRENT ⁽¹⁾ Input Bias Current Input Offset Current	V _{CM} = 0V V _{CM} = 0V		50 ±3		pA pA
NOISE Input Voltage Noise Noise Density: f = 10Hz f = 100Hz f = 1kHz f = 10kHz Voltage Noise, BW = 20Hz to 20kHz Input Bias Current Noise Current Noise Density, f = 0.1Hz to 20kHz			25 15 11 10 1.5 4		nV/√Hz nV/√Hz nV/√Hz nV/√Hz μV _{PP} fA/√Hz
INPUT VOLTAGE RANGE Common-Mode Input Range Common-Mode Rejection	V _{CM} = ±12V	±12 80	±13 100		V dB
INPUT IMPEDANCE Differential Common-Mode			10 ¹² 8 10 ¹² 10		Ω pF Ω pF
OPEN-LOOP GAIN Open-Loop Voltage Gain	V _O = ±10V, R _L = 1kΩ	80	100		dB
FREQUENCY RESPONSE Gain-Bandwidth Product Slew Rate Settling Time: 0.01% 0.1% Total Harmonic Distortion + Noise (THD+N)	G = 100 20V _{PP} , R _L = 1kΩ G = -1, 10V Step G = 1, f = 1kHz V _O = 3.5Vrms, R _L = 1kΩ	15	20 25 1.5 1 0.0003		MHz V/μs μs μs %
OUTPUT Voltage Output Current Output Short Circuit Current Output Resistance, Open-Loop	R _L = 600Ω V _O = ±12V	±11	±12 ±35 ±40 25		V mA mA Ω
POWER SUPPLY Specified Operating Voltage Operating Voltage Range Current		±4.5	±15 ±5.3	±24 ±7	V V mA
TEMPERATURE RANGE Specification Storage Thermal Resistance ⁽²⁾ , θ _{JA}		-25 -40	90	+85 +125	°C °C °C/W

NOTES: (1) Typical performance, measured fully warmed-up. (2) Soldered to circuit board—see text.

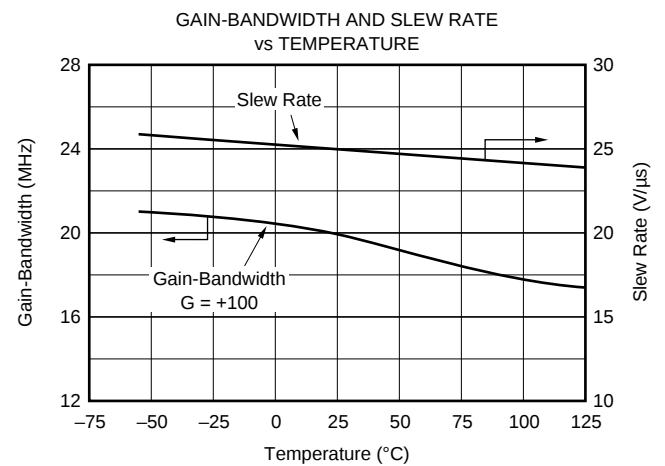
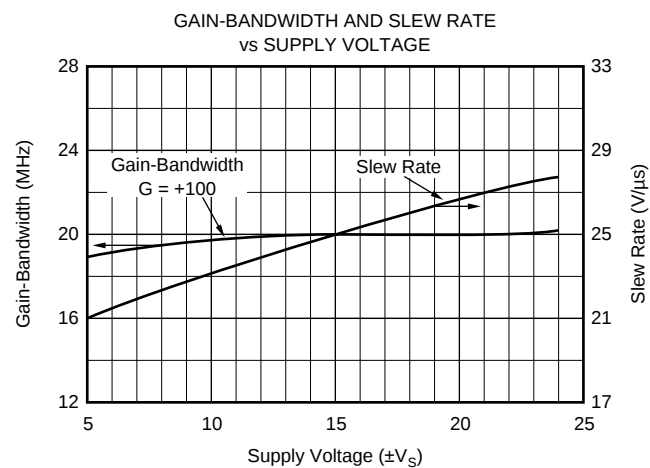
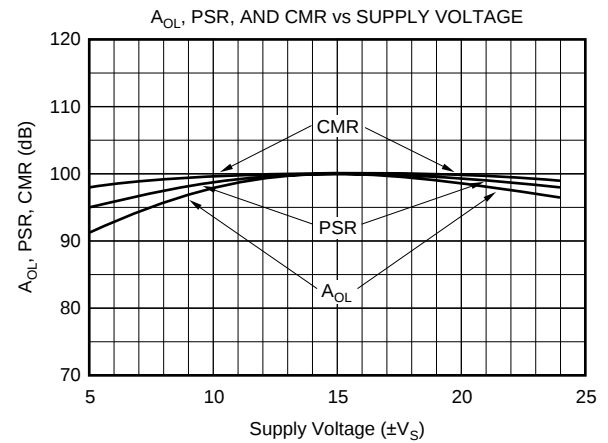
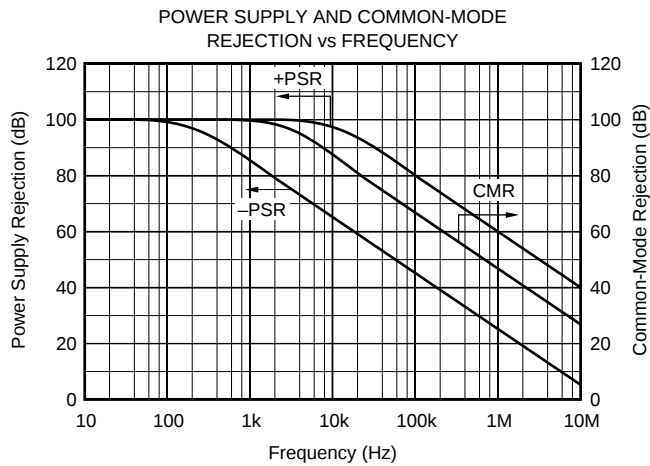
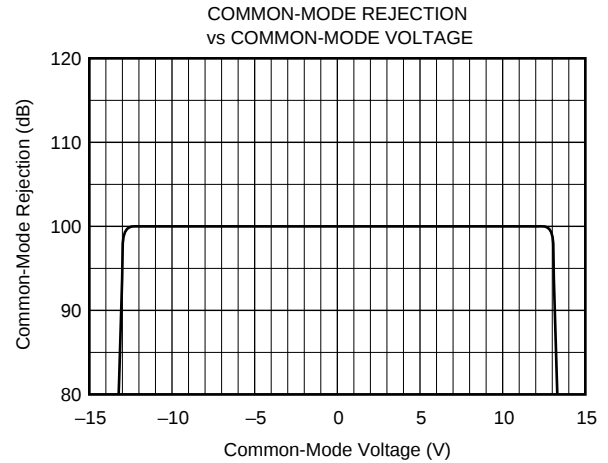
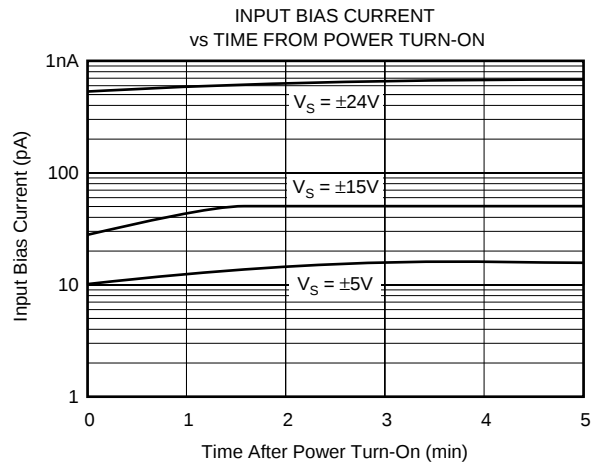
TYPICAL CHARACTERISTICS

$T_A = +25^\circ\text{C}$, $V_S = \pm 15\text{V}$, unless otherwise noted.



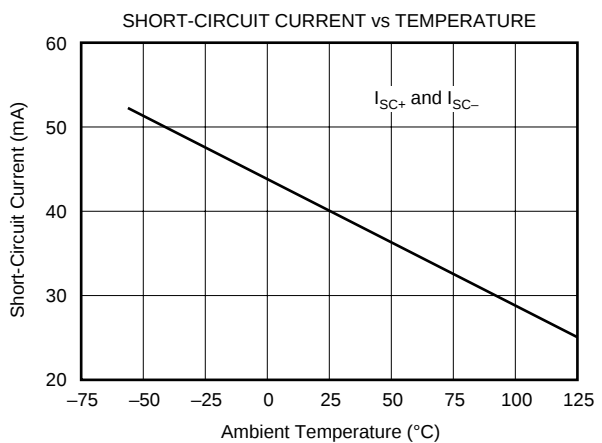
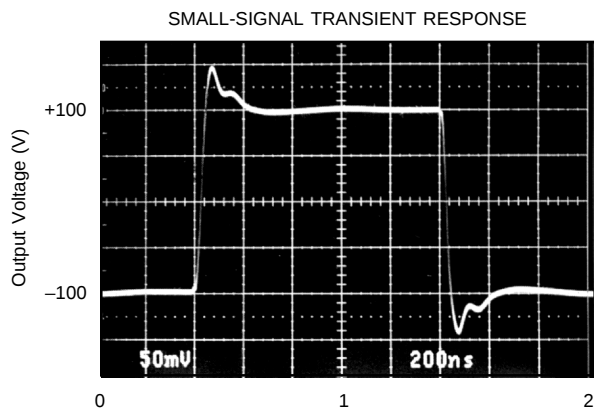
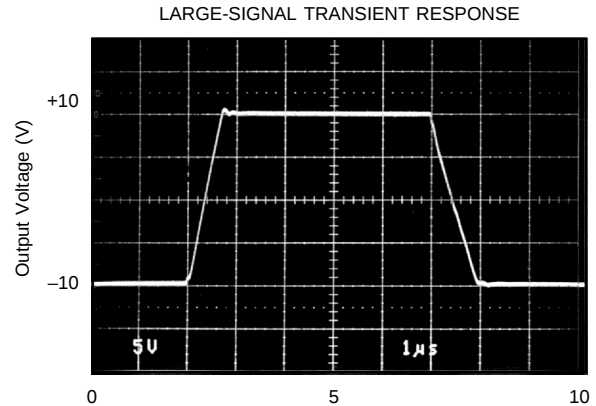
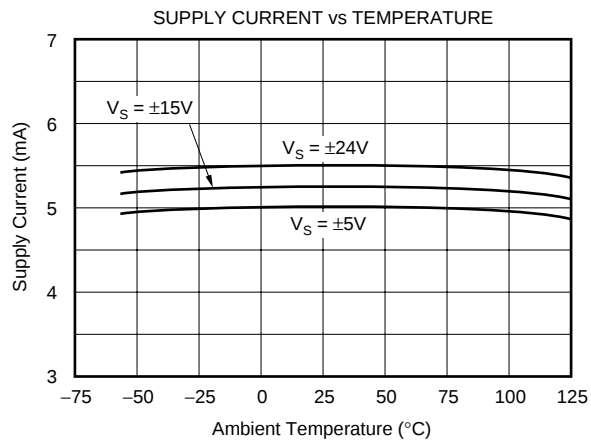
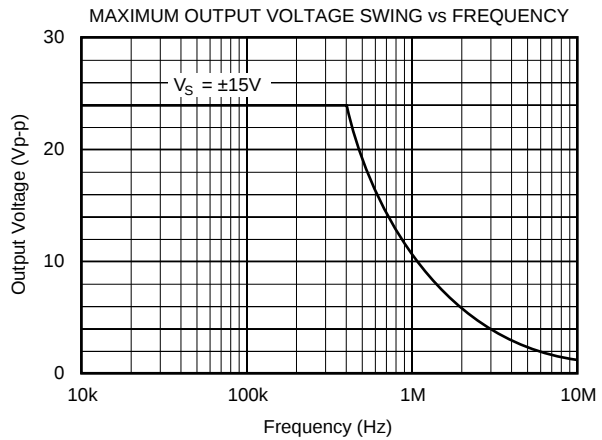
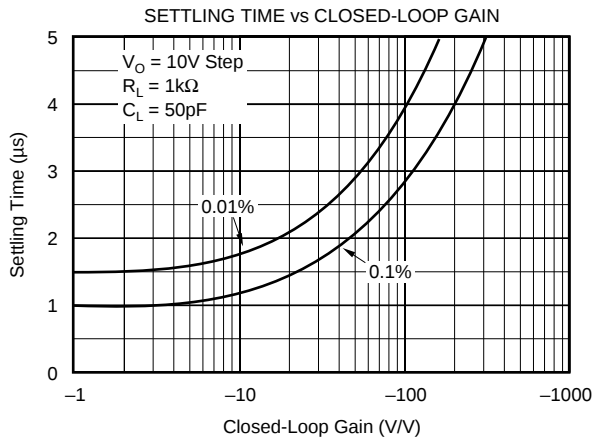
TYPICAL CHARACTERISTICS (Cont.)

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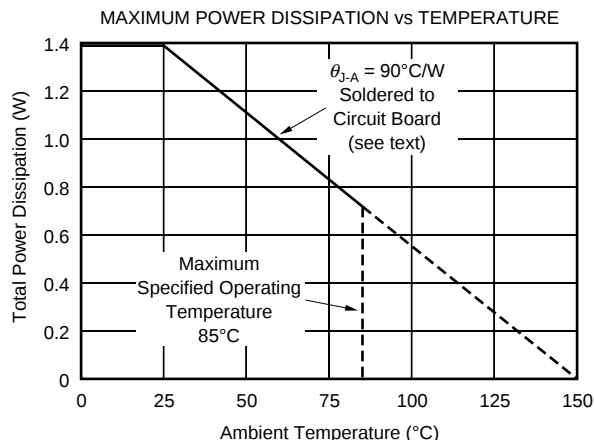
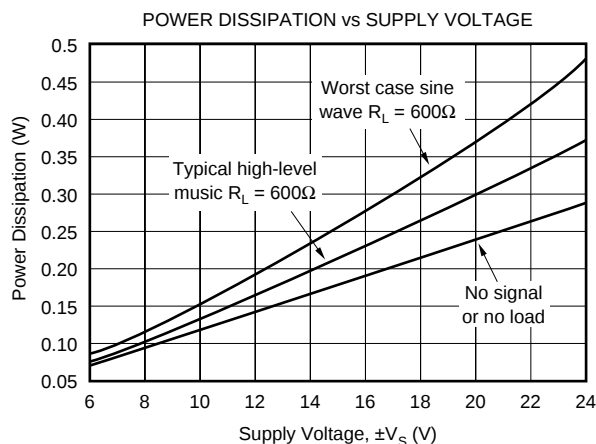
TYPICAL CHARACTERISTICS (Cont.)

$T_A = +25^\circ\text{C}$, $V_S = \pm 15\text{V}$, unless otherwise noted.



TYPICAL CHARACTERISTICS (Cont.)

$T_A = +25^\circ\text{C}$, $V_S = \pm 15\text{V}$, unless otherwise noted.



APPLICATIONS INFORMATION

OFFSET VOLTAGE ADJUSTMENT

The OPA604 offset voltage is laser-trimmed and will require no further trim for most applications. As with most amplifiers, externally trimming the remaining offset can change drift performance by about $0.3\mu\text{V}/^\circ\text{C}$ for each $100\mu\text{V}$ of adjusted offset. The OPA604 can replace many other amplifiers by leaving the external null circuit unconnected.

The OPA604 is unity-gain stable, making it easy to use in a wide range of circuitry. Applications with noisy or high impedance power supply lines may require decoupling capacitors close to the device pins. In most cases, a $1\mu\text{F}$ tantalum capacitor at each power supply pin is adequate.

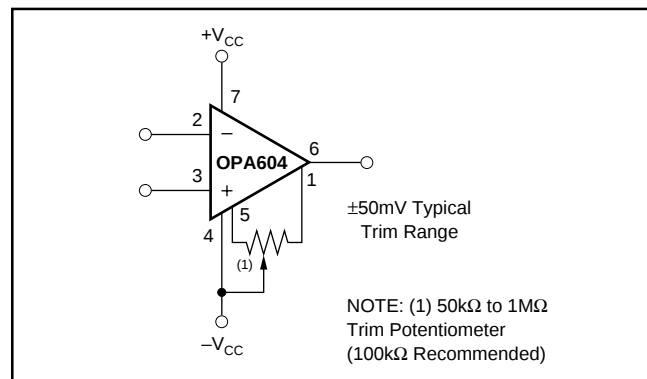


FIGURE 1. Offset Voltage Trim.

DISTORTION MEASUREMENTS

The distortion produced by the OPA604 is below the measurement limit of virtually all commercially available equipment. A special test circuit, however, can be used to extend the measurement capabilities.

Op amp distortion can be considered an internal error source which can be referred to the input. Figure 2 shows a circuit which causes the op amp distortion to be 101 times greater than normally produced by the op amp. The addition of R_3 to the otherwise standard noninverting amplifier configuration alters the feedback factor or noise gain of the circuit. The closed-loop gain is unchanged, but the feedback available for error correction is reduced by a factor of 101. This extends the measurement limit, including the effects of the signal-source purity, by a factor of 101. Note that the input signal and load applied to the op amp are the same as with conventional feedback without R_3 .

Validity of this technique can be verified by duplicating measurements at high gain and/or high frequency where the distortion is within the measurement capability of the test equipment. Measurements for this data sheet were made with the Audio Precision System One, which greatly simplifies such repetitive measurements. The measurement technique can, however, be performed with manual distortion measurement instruments.

CAPACITIVE LOADS

The dynamic characteristics of the OPA604 have been optimized for commonly encountered gains, loads and operating conditions. The combination of low closed-loop gain and capacitive load will decrease the phase margin and may lead to gain peaking or oscillations. Load capacitance reacts with the op amp's open-loop output resistance to form an additional pole in the feedback loop. Figure 3 shows various circuits which preserve phase margin with capacitive load. For details of analysis techniques and applications circuits, refer to application bulletin AB-028 (SBOA015) located at www.ti.com.

For the unity-gain buffer, Figure 3a, stability is preserved by adding a phase-lead network, R_C and C_C . Voltage drop across R_C will reduce output voltage swing with heavy loads. An alternate circuit, Figure 3b, does not limit the output with low load impedance. It provides a small amount of positive feedback to reduce the net feedback factor. Input impedance of this circuit falls at high frequency as op amp gain rolloff reduces the bootstrap action on the compensation network.

Figures 3c and 3d show compensation techniques for noninverting amplifiers. Like the follower circuits, the circuit in Figure 3d eliminates voltage drop due to load current, but at the penalty of somewhat reduced input impedance at high frequency.

Figures 3e and 3f show input lead compensation networks for inverting and difference amplifier configurations.

NOISE PERFORMANCE

Op amp noise is described by two parameters—noise voltage and noise current. The voltage noise determines the noise performance with low source impedance. Low noise bipolar-input op amps such as the OPA27 and OPA37 provide very low voltage noise. But if source impedance is greater than a few thousand ohms, the current noise of

bipolar-input op amps react with the source impedance and will dominate. At a few thousand ohms source impedance and above, the OPA604 will generally provide lower noise.

POWER DISSIPATION

The OPA604 is capable of driving a 600Ω load with power-supply voltages up to $\pm 24V$. Internal power dissipation is increased when operating at high power supply voltage. The typical characteristic curve, Power Dissipation vs Power Supply Voltage, shows quiescent dissipation (no signal or no load) as well as dissipation with a worst case continuous sine wave. Continuous high-level music signals typically produce dissipation significantly less than worst-case sine waves.

Copper leadframe construction used in the OPA604 improves heat dissipation compared to conventional plastic packages. To achieve best heat dissipation, solder the device directly to the circuit board and use wide circuit board traces.

OUTPUT CURRENT LIMIT

Output current is limited by internal circuitry to approximately $\pm 40mA$ at $25^\circ C$. The limit current decreases with increasing temperature as shown in the typical curves.

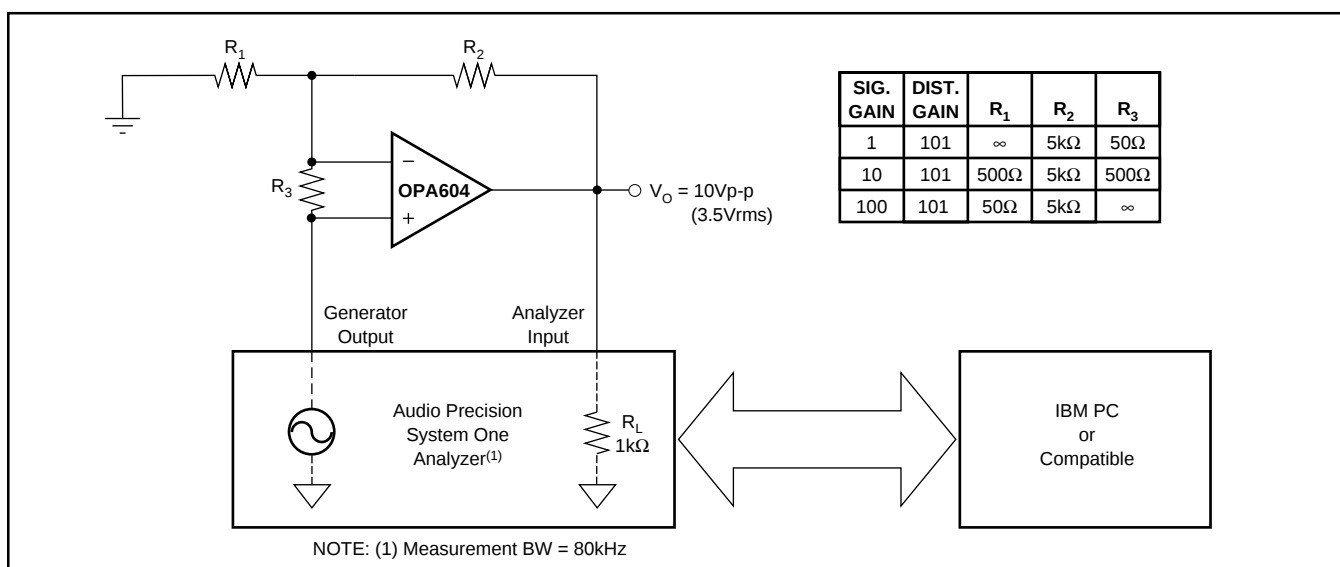
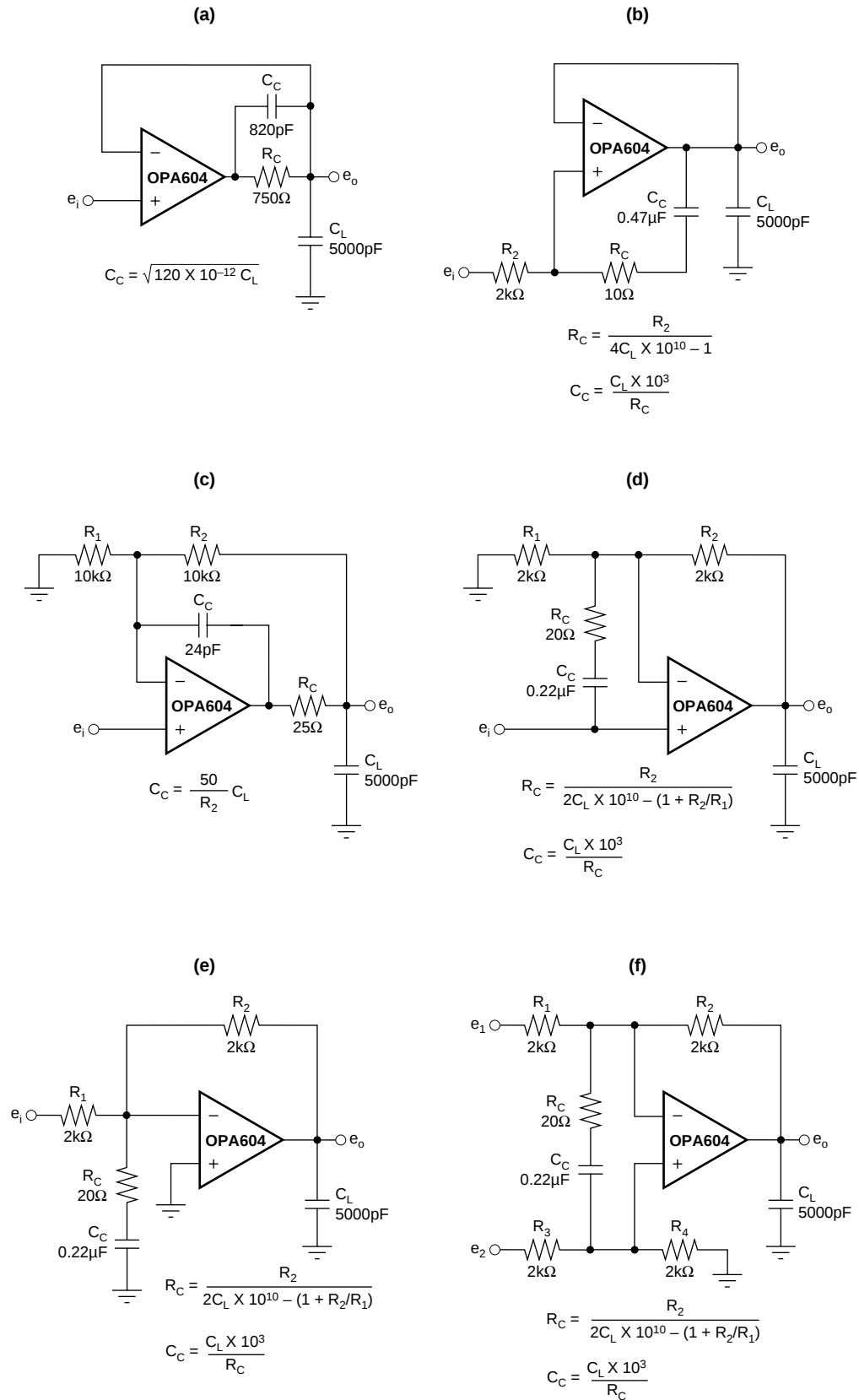


FIGURE 2. Distortion Test Circuit.



NOTE: Design equations and component values are approximate. User adjustment is required for optimum performance.

FIGURE 3. Driving Large Capacitive Loads.

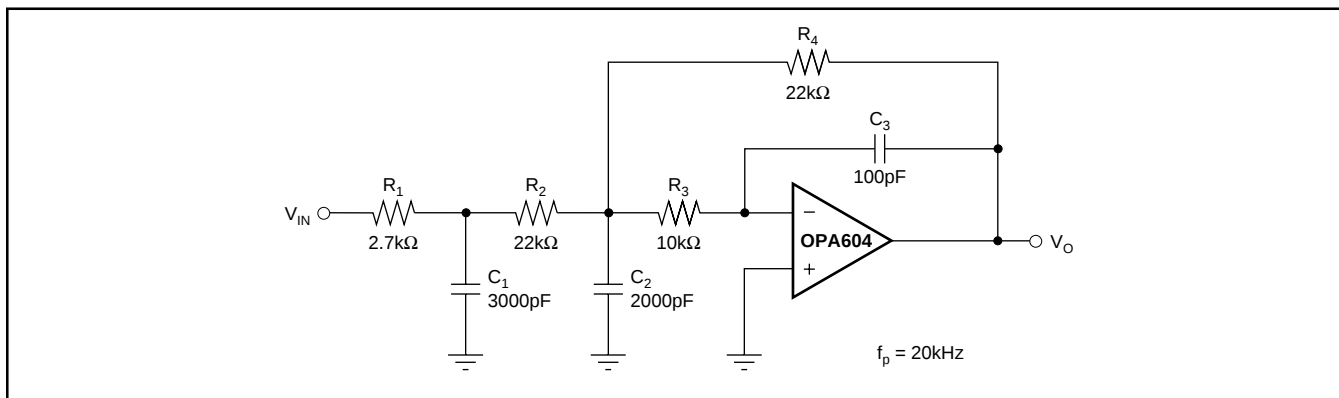


FIGURE 4. Three-Pole Low-Pass Filter.

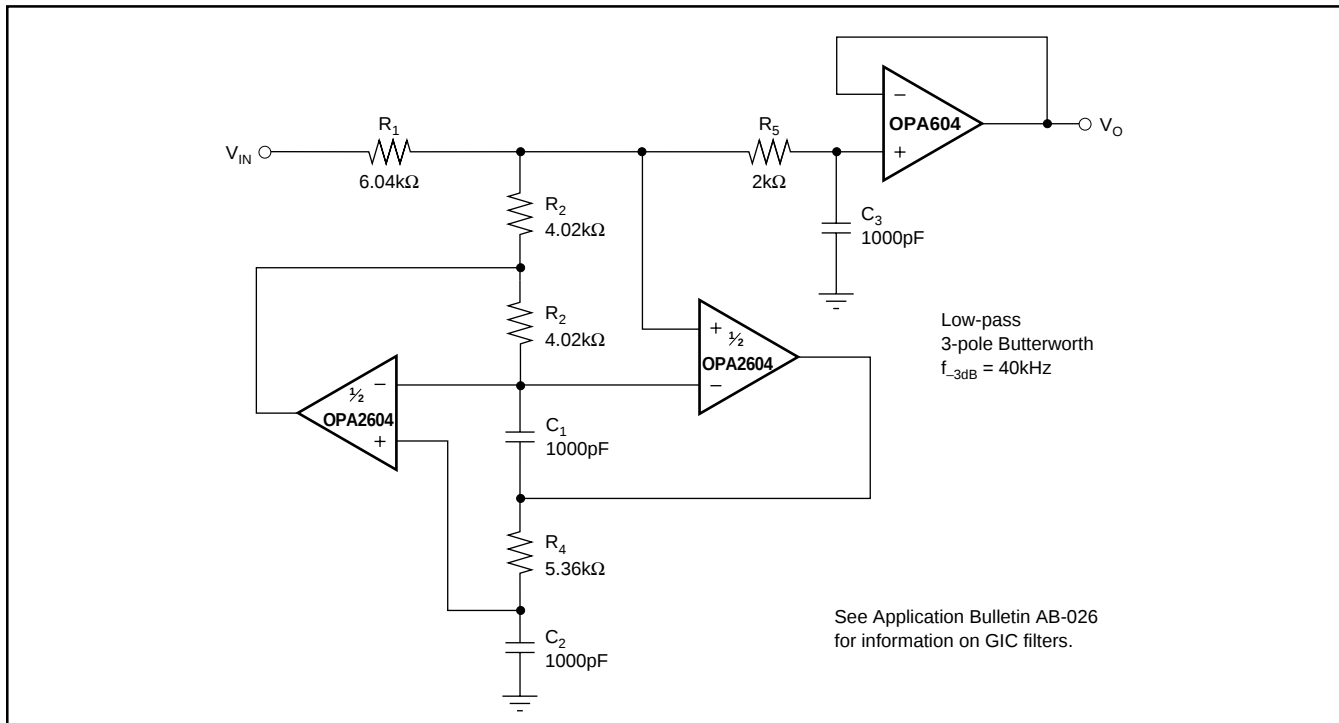


FIGURE 5. Three-Pole Generalized Immittance Converter (GIC) Low-Pass Filter.

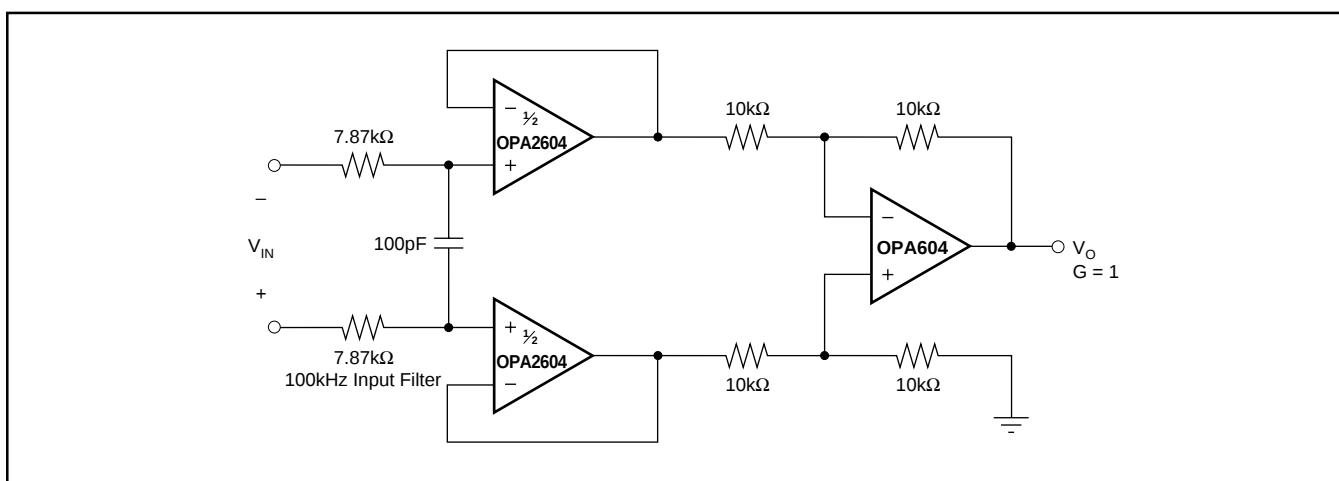


FIGURE 6. Differential Amplifier with Low-Pass Filter.

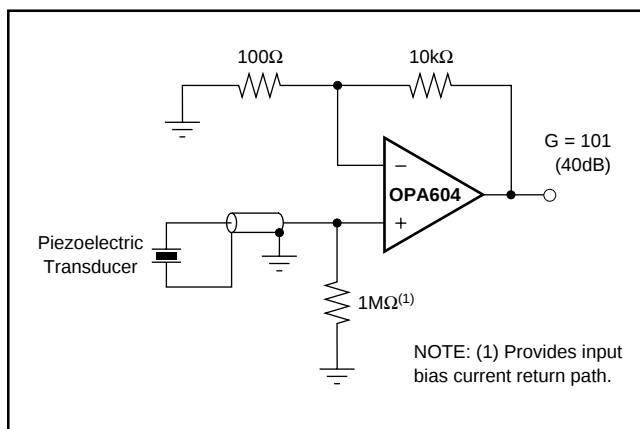


FIGURE 7. High Impedance Amplifier.

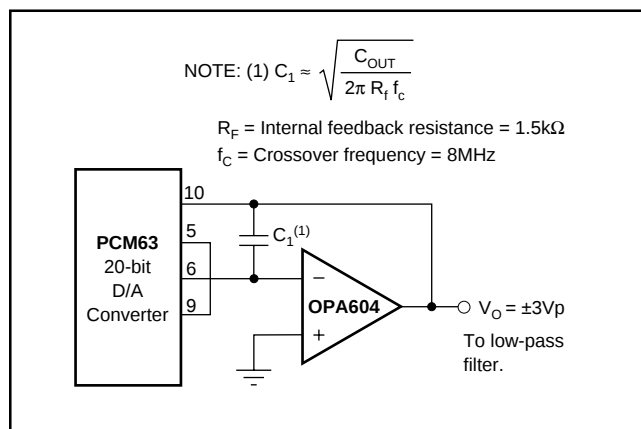


FIGURE 8. Digital Audio DAC I-V Amplifier.

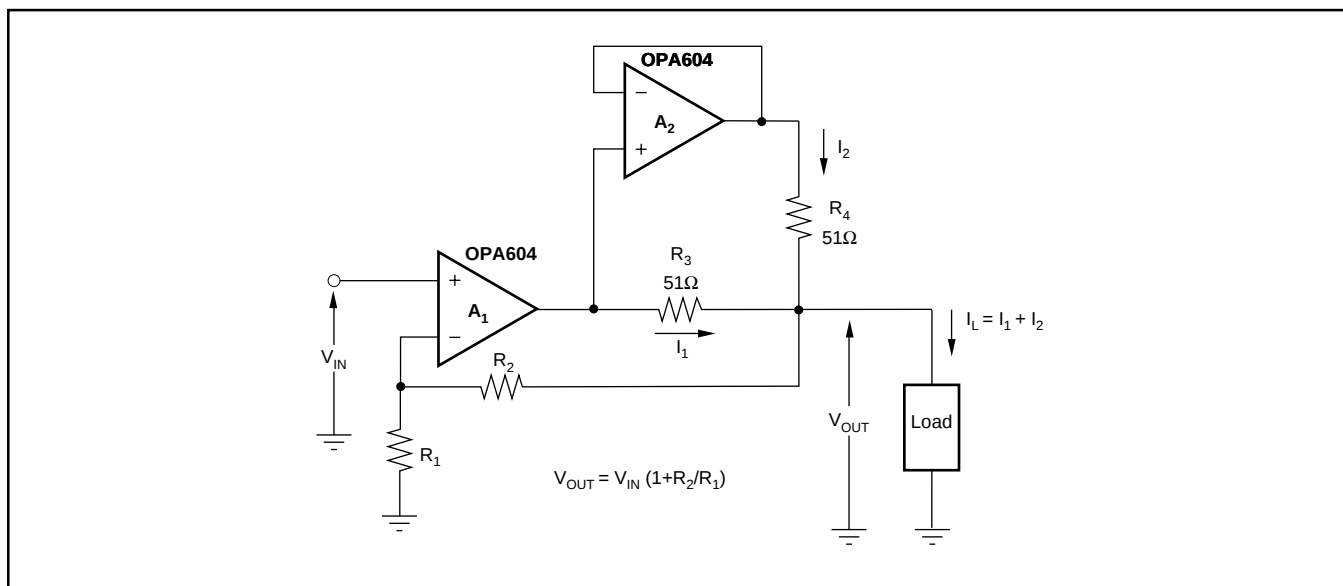


FIGURE 9. Using Two OPA604 Op Amps to Double the Output Current to a Load.

SOUND QUALITY

The following discussion is provided, recognizing that not all measured performance behavior explains or correlates with listening tests by audio experts. The design of the OPA604 included consideration of both objective performance measurements, as well as an awareness of widely held theory on the success and failure of previous op amp designs.

SOUND QUALITY

The sound quality of an op amp is often the crucial selection criteria—even when a data sheet claims exceptional distortion performance. By its nature, sound quality is subjective. Furthermore, results of listening tests can vary depending on application and circuit configuration. Even experienced listeners in controlled tests often reach different conclusions.

Many audio experts believe that the sound quality of a high performance FET op amp is superior to that of bipolar op amps. A possible reason for this is that bipolar designs generate greater odd-order harmonics than FETs. To the human ear, odd-order harmonics have long been identified as sounding more unpleasant than even-order harmonics. FETs, like vacuum tubes, have a square-law I-V transfer function which is more linear than the exponential transfer function of a bipolar transistor. As a direct result of this square-law characteristic, FETs produce predominantly even-order harmonics. Figure 10 shows the transfer function of a bipolar transistor and FET. Fourier transformation of both transfer functions reveals the lower odd-order harmonics of the FET amplifier stage.

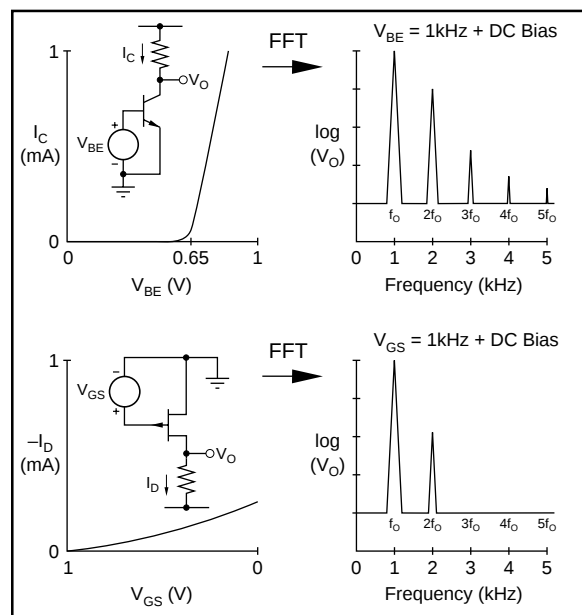
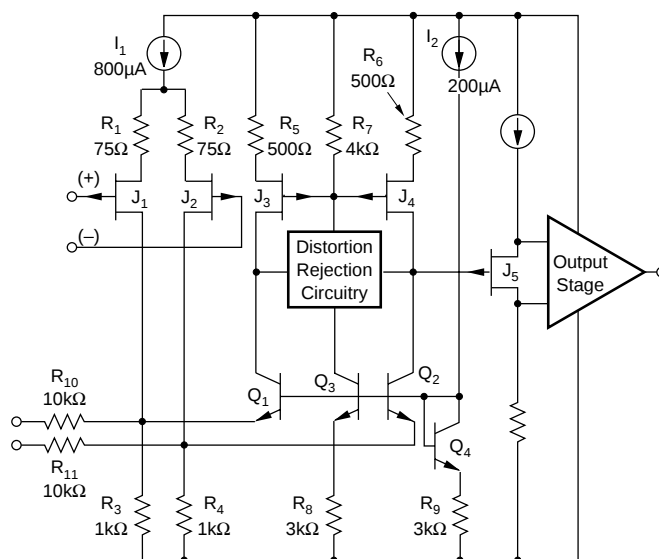


FIGURE 10. I-V and Spectral Response of NPN and JFET.



THE OPA604 DESIGN

The OPA604 uses FETs throughout the signal path, including the input stage, input-stage load, and the important phase-splitting section of the output stage. Bipolar transistors are used where their attributes, such as current capability are important, and where their transfer characteristics have minimal impact.

The topology consists of a single folded-cascode gain stage followed by a unity-gain output stage. Differential input transistors J₁ and J₂ are special large-geometry, P-channel JFETs. Input stage current is a relatively high 800µA, providing high transconductance and reducing voltage noise. Laser trimming of stage currents and careful attention to symmetry yields a nearly symmetrical slew rate of ±25V/µs.

The JFET input stage holds input bias current to approximately 50pA or roughly 3000 times lower than common bipolar-input audio op amps. This dramatically reduces noise with high-impedance circuitry.

The drains of J₁ and J₂ are cascoded by Q₁ and Q₂, driving the input stage loads, FETs J₃ and J₄. Distortion reduction circuitry (patented) linearizes the open-loop response and increases voltage gain. The 20MHz bandwidth of the OPA604 further reduces distortion through the user-connected feedback loop.

The output stage consists of a JFET phase-splitter loaded into high speed all-NPN output drivers. Output transistors are biased by a special circuit to prevent cutoff, even with full output swing into 600Ω loads.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
OPA604AU	Active	Production	SOIC (D) 8	75 TUBE	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	OPA 604AU
OPA604AU.A	Active	Production	SOIC (D) 8	75 TUBE	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	OPA 604AU
OPA604AU/2K5	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	OPA 604AU
OPA604AU/2K5.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	OPA 604AU

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
OPA604AU/2K5	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
OPA604AU/2K5	SOIC	D	8	2500	353.0	353.0	32.0

TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
OPA604AU	D	SOIC	8	75	506.6	8	3940	4.32
OPA604AU.A	D	SOIC	8	75	506.6	8	3940	4.32



PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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